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# PRODUCT SPECIFICATION SHEET

| | | |
|---|---|---|
| CUSTOMER | : | |
| PRODUCT TYPE | : | SMD X'TAL 2.5*2.0(4PAD) |
| NOMINAL FREQ. | : | 40.000000 MHz |
| FL P/N | : | 2S40000074 |
| REVISION | : | S1 |
| CUSTOMER P/N | : | |

CUSTOMER'S APPROVAL&DATE

FL CORPORATION

| APPROVED | CHECKED | DESIGNED |
|---|---|---|
| Xing Yue | Liao Xiaohua | Li Xiang |

MSL1

RoHS Compliant

**CONTENTS** **PAGE**


- SPECIFICATION REVISION RECORD SHEET 2
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**ATTACHMENT（optional）**

- ELECTRICAL CHARACTERISTICS TEST A ☐ YES ☑ NO
- TEMPERATURE CHARACTERISTICS TEST B ☐ YES ☑ NO

**Attention**

- If you intend to use products on the controlling equipment that relate to medical, aeronautical, aerospace, military science, space and etc, please make sure to let us know your intentions in advance.
- Ultrasonic related process may cause damage to crystal blank by resonance itself. If ultrasonic related process is used, we strongly recommend to assess the damage risk under related ultrasonic conditions before use in production.

## SPECIFICATION REVISION RECORD SHEET

| Rev. | Revise page | Revise Contents | Date | Ref. No. | Reviser |
|---|---|---|---|---|---|
| S0 | N/A | Initial released | 27-Nov-22 | N/A | Li Xiang |
| S1 | P.1 | Add attention information | 18-Jul-23 | N/A | Li Xiang |
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## PRODUCT DESCRIPION

**Standard atmospheric conditions**

Unless otherwise specified. The standard range of atmospheric conditions for making measurement and tests are as follow:

Ambient temperature 25±2℃
Relative humidity 40%~70%

If there is no doubt the results, measurement shall be made within the following limits:

Ambient temperature 25±2℃
Relative humidity : 40%~70%

**Measure equipment**

Electrical characteristics measured by S&A250B or equivalent.

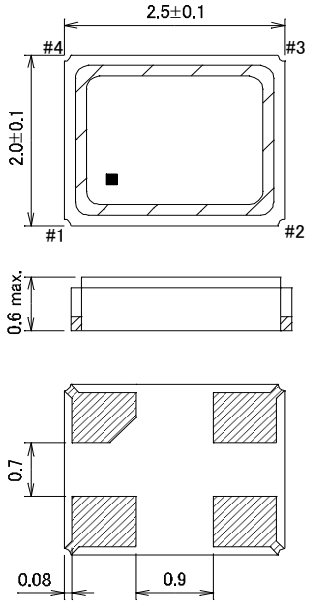
**Crystal cutting type**

The crystal is using AT CUT (thickness shear mode)

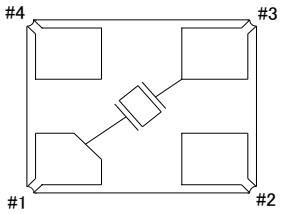
## ELECTRICAL SPECIFICATIONS

| No. | Items | Electrical Spec. | | | | | Remarks |
|---|---|---|---|---|---|---|---|
| | | Symbol | Min | Typ | Max | Units | |
| 1 | Nominal Frequency | FL | 40.000000 | | | MHz | - |
| 2 | Oscillation Mode | - | Fundamental | | | - | - |
| 3 | Load Capacitance | CL | 8.0 | | | pF | - |
| 4 | Frequency Tolerance | - | ±10 | | | ppm | at 25±2℃ |
| 5 | Frequency Stability | - | ±20 | | | ppm | at -40～+85℃ (reference 25℃) |
| 6 | Shunt Capacitance | C0 | - | - | 5 | pF | - |
| 7 | Aging (/1 year) | - | ±3 | | | ppm/year | at 25±2℃ |
| 8 | Operating Temperature | - | -40 | - | 85 | ℃ | - |
| 9 | Storage Temperature | - | -40 | - | 105 | ℃ | - |
| 10 | Equivalent series resistance | ESR | - | - | 40 | ohms | - |
| 11 | Insulation Resistance | IR | 500 | - | - | M-ohms | at DC 100V |
| 12 | ESD | - | HBM＞4000V | | | - | ANSI/ESDA/JEDEC JS-001 |
| 13 | MSL | - | Level 1 | | | - | J-STD-020 |
| 14 | Drive Level | DL | - | - | 100 | uW | - |

## DIMENSIONS unit:mm

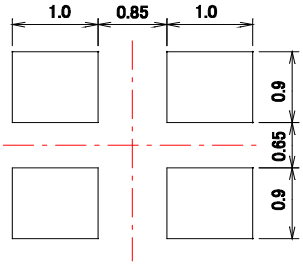



## CONNECTION DIAGRAM (TOP VIEW)

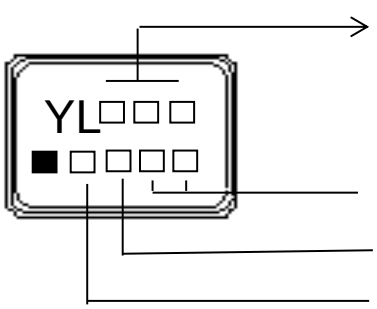



| Pin | Function |
|---|---|
| #1 | Xtal terminal (Input) |
| #2 | GND terminal |
| #3 | Xtal terminal (Output) |
| #4 | GND terminal |

## LAND PATTERN unit:mm




## MARKING




**Frequency**
**EX: 40.000MHz = 400**

**lot (2 digits)**

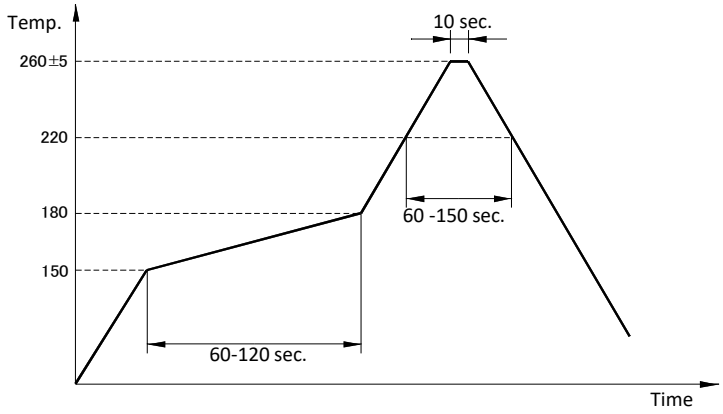
**year month**

**Administrative Symbol**

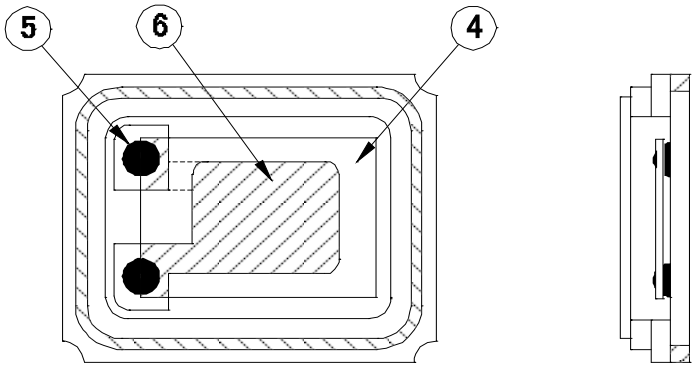
| year \ month | | JAN | FEB | MAR | APR | MAY | JUN | JUL | AUG | SEP | OCT | NOV | DEC |
|---|---|---|---|---|---|---|---|---|---|---|---|---|---|
| 2021 | 2025 | A | B | C | D | E | F | G | H | J | K | L | M |
| 2022 | 2026 | N | P | Q | R | S | T | U | V | W | X | Y | Z |
| 2023 | 2027 | a | b | c | d | e | f | g | h | j | k | l | m |
| 2024 | 2028 | n | p | q | r | s | t | u | v | w | x | y | z |

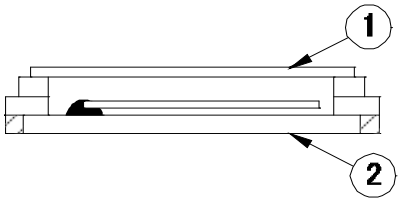
## SUGGESTED REFLOW PROFILE

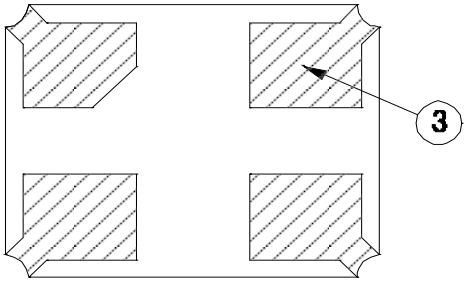
Total time : 360 sec. Max.
Solder melting point :225 °C



## STRUCTURE ILLUSTRATION




| NO | COMPONENTS | MATERIALS | QTY | FINISH/SPECIFICATIONS |
|---|---|---|---|---|
| 1 | Cap(Lid) | Kovar(Fe+Co+Ni) | 1 | Ni plating |
| 2 | Base(Package) | Almina Ceramics ($Al_2O_3$) | 1 | |
| 3 | Pad(Package) | Ni + Au | 4 | Ni+Au plating |
| 4 | Crystal blank | $SiO_2$ | 1 | - |
| 5 | Conductive adhesive | Ag | 2 | Silicone resin |
| 6 | Electrode | Noble metal | 2 | - |

## RELIABILITY SPECIFICATIONS

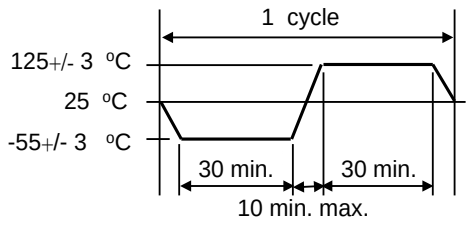
1.MECHANICAL ENDURANCE

| No. | Test Item | Test Methods | |
|---|---|---|---|
| 1 | Drop Test | 150 cm height, fall freely onto stainless plate 3 times. | JIS C6701 |
| 2 | Shock Test | 150g/150cm Height,3times in the direction of ±x, ±y, ±z on concrete floor | IEC-68-02-27 |
| 3 | Mechanical Shock | Device are shocked to half sine wave ( 1000 G ) three mutua pendicular axes each 3 times. 1.0m sec. duration time | MIL-STD-202F |
| 4 | Vibration | Frequency range 10 ~ 55 Hz<br>Amplitude 1.52 mm<br>Pendicular axes each test tim 2 hours（x,y,z Axis）<br>Total test time 6 hours | MIL-STD-883E |
| 5 | Gross Leak | Standard Sample For Automatic Gross Leak Detector Test Pressure 2kg/cm2 | MIL-STD-883E |
| 6 | Fine Leak | Helium Bombing 4.5kgf/cm2 for 2 hr | MIL-STD-883E |
| 7 | Solderability | Temperature 260 °C ±5 °C<br>Immersing depth 0.5 mm minimum<br>Immersion time 5 ± 1 seconds<br>Flux Rosin resin methyl alcohol solvent ( 1 : 4 ) | GB/T 2424.17-2008 / IEC 60068-2-44:1995; GB/T 2423.28-2005 / IEC 60068-2-20:1979 |
| 8 | Resistance To Soldering Heat | Pre-heat temperature 125 °C<br>Pre-heat time 60 ~ 120 sec.<br>Test temperature 260 +/- 5 °C<br>Test time 5 +/- 1 sec. | MIL-STD-202F |

*Storage conditions： 18 months

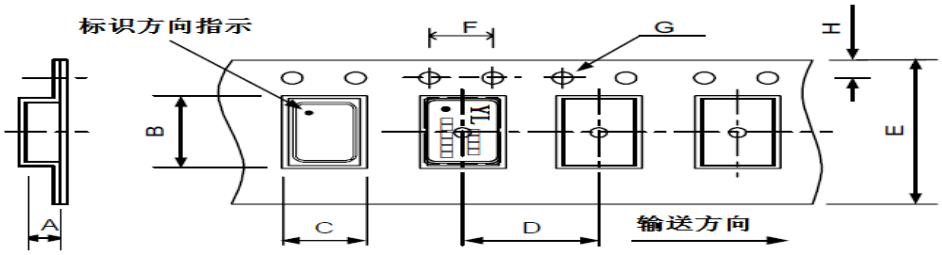
*Constant humidity： 40~70%

2.ENVIRONMENTAL ENDURANCE

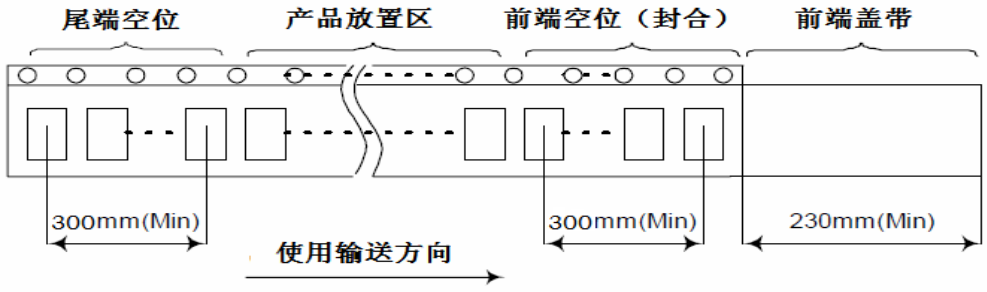
| No. | Test Item | Test Methods | |
|---|---|---|---|
| 9 | High Temp. Storage | + 125 °C +/- 3 °C for 500 +/- 12 hours | MIL-STD-883E |
| 10 | Low Temp. Storage | - 40 °C +/- 3 °C for 500 +/- 12 hours | |
| 11 | Thermal Shock | Total 100 cycles of the following temperature cycle   | MIL-STD-883E |
| 12 | High Temp&Homidity | 85℃±3℃, RH 85%,500Hrs | JIS C5023 |

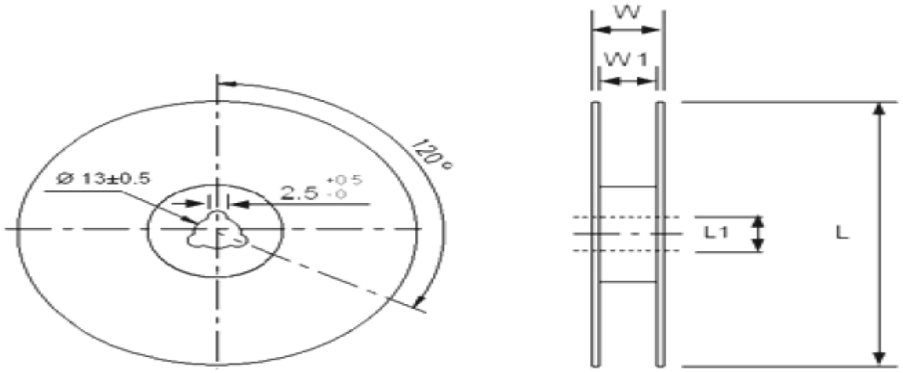
**PACKING :**

8mm-4mm，3000pcs / reel， ϕ178；




| Dimension | A | B | C | D | E | F | G | H | Unit：mm |
|---|---|---|---|---|---|---|---|---|---|
| | 1.55 ±0.1 | 2.70 ±0.1 | 2.25 ±0.1 | 4.00 | 8.00 | 4.00 | 1.50 | 1.75 | |




| Dimension | L | L1 | W | W1 | Unit：mm |
|---|---|---|---|---|---|
| | 178 | 13 | 11.5 | 8 | 3000pcs / reel |

## SMD PRODUCT PACKING STANDARD

### Out-going packing instruction

| Reel Packing | Inner Packing | Carton |
|---|---|---|
| name：reel<br>standard：diameter 18cm<br>material：plastics | name：Bubble Wrap<br>standard：430×330+20mm<br>material：HDPE(15 reels enter) | name：carton<br>standard：400×400×280mm<br>material：AB corrugated paper(4 bags enter) |
|  |  | <br> |

### The label instruction

| Label Drawing | Mark | Name of Article | Spec. | Size | Printing |
|---|---|---|---|---|---|
|  | L1 | 条码标签<br>Bar Code Label<br>(Chintz Paper) | 1.Part No.<br>2.Lot No.<br>3.Q'ty<br>4.Freq | 70x50mm | White |
|  | L2 | 条码标签<br>Bar Code Label<br>(Chintz Paper) | 1.Part No.<br>2.Date Code<br>3.Q'ty<br>4.Freq | 70x50mm | White |

**Remark**

Specifications on the label is for the use of templates with different product specifications may vary. If customer specified requirements for labels packaging. please provide the operation procedure.

| Range | Products | Packing Material |
|---|---|---|
| **Banned Substances** | **Maximum concentration ppm(mg/kg)** | **Maximum concentration ppm(mg/kg)** |
| 1.镉及镉化合物<br>Cadmium and cadmium compounds | 100 | 100 |
| 2.铅及铅化合物<br>Lead and lead compounds | 1000 | 100 |
| 3.汞及汞化合物<br>Mercury and mercury compounds | 1000 | 100 |
| 4.六价铬化合物<br>Hexavalent-Chromium VI (Cr+6) | 1000 | 100 |
| 5.聚溴联苯 PBB<br>Polybrominated biphenyls | 1000 | N/A |
| 6.聚溴二苯醚 PBDE<br>Polybrominated diphenyl ethers | 1000 | N/A |
| 7.邻苯二甲酸二(2-乙基已基)酯 DEHP<br>Di (2-ethylhexyl) phthalate | 1000 | N/A |
| 8.邻苯二甲酸丁苄酯 BBP<br>Butyl Benzyl Phthalate | 1000 | N/A |
| 9.邻苯二甲酸二丁酯 DBP<br>Dibutyl Phthalate | 1000 | N/A |
| 10 邻苯二甲酸二异丁酯 DIBP<br>Diisobutyl Phthalate | 1000 | N/A |
| 11. 氟（F）、氯（Cl）、溴（Br）、碘（I）<br>Fluorine、Chlorine、 Bromine、 | 900、900、900、900<br>注：Br+Cl＜1000 | N/A |
| 12.包装材料中重金属(汞、镉、六价铬、铅、PBB、PBDE)之总量<br>Heavy metals (mercury, cadmium, lead, Cr+6,PBB and PBDE) in packing materials | N/A | 100<br>铅(Pb) + 镉(Cd) + 汞(Hg) + 六价铬(Cr+6) <100ppm |
| 13.高度关注物质<br>SVHC-Substances of Very High Concern | 1000 | N/A |


惠伦晶体
FAITH LONG CRYSTAL